

TXB0108 8-Bit Bidirectional Voltage-Level Translator with Auto-Direction Sensing and ±15-kV ESD Protection

1 Features

- 1.2 V to 3.6 V on A Port and 1.65 V to 5.5 V on B Port ($V_{CCA} \le V_{CCB}$)
- V_{CC} Isolation Feature If Either V_{CC} Input Is at GND, All Outputs Are in the High-Impedance State
- OE Input Circuit Referenced to V_{CCA}
- Low Power Consumption, 4-µA Max I_{CC}
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78. Class II
- ESD Protection Exceeds JESD 22
 - A Port
 - 2000-V Human-Body Model (A114-B)
 - 1000-V Charged-Device Model (C101)
 - B Port
 - ±15-kV Human-Body Model (A114-B)
 - ±8-kV Human-Body Model (A114-B) (YZP Package Only)
 - 1000-V Charged-Device Model (C101)

2 Applications

- Handset
- Smartphone
- **Tablet**
- Desktop PC

3 Description

This 8-bit noninverting translator uses two separate configurable power-supply rails. The A port is designed to track V_{CCA}. V_{CCA} accepts any supply voltage from 1.2 V to 3.6 V. The B port is designed to track V_{CCB}. V_{CCB} accepts any supply voltage from 1.65 V to 5.5 V. This allows for universal low-voltage bidirectional translation between any of the 1.2-V, 1.5-V, 1.8-V, 2.5-V, 3.3-V, and 5-V voltage nodes. V_{CCA} should not exceed V_{CCB}.

When the output-enable (OE) input is low, all outputs are placed in the high-impedance state.

The TXB0108 is designed so that the OE input circuit is supplied by V_{CCA}.

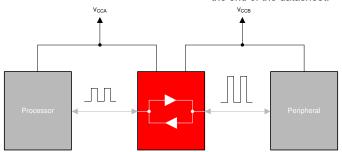
This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

To ensure the high-impedance state during power-up or power-down, OE should be tied to GND through a pulldown resistor: the minimum value of the resistor is determined by the current-sourcing capability of the driver.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)
TXB0108DQS	SON (20)	2.00 mm x 4.00 mm
TXB0108ZXY	BGA MICROSTAR JUNIOR (20)	2.50 mm x 3.00 mm
TXB0108PW	TSSOP (20)	6.50 mm x 4.40 mm
TXB0108RGY	VQFN (20)	4.50 mm x 3.50 mm
TXB0108YZP	DSGBA (20)	1.90 mm x 2.40 mm
TXB0108NME	nFBGA (20)	2.50 mm x 3.00 mm

For all available packages, see the orderable addendum at the end of the datasheet.



Typical Application Block Diagram for TXB0108



Table of Contents

1 Features1	7 Parameter Measurement Information	. 12
2 Applications 1	8 Detailed Description	.13
B Description1	8.1 Overview	13
4 Revision History2	8.2 Functional Block Diagram	13
5 Pin Configuration and Functions3	8.3 Feature Description	.14
Specifications5	8.4 Device Functional Modes	
6.1 Absolute Maximum Ratings5	9 Application and Implementation	16
6.2 Handling Ratings5	9.1 Application Information	16
6.3 Recommended Operating Conditions5	9.2 Typical Application	
6.4 Thermal Information6	10 Power Supply Recommendations	.18
6.5 Electrical Characteristics6	11 Layout	18
6.6 Timing Requirements: V _{CCA} = 1.2 V7	11.1 Layout Guidelines	18
6.7 Timing Requirements: V _{CCA} = 1.5 V ± 0.1 V	11.2 Layout Example	18
6.8 Timing Requirements: V _{CCA} = 1.8 V ± 0.15 V7	12 Device and Documentation Support	.19
6.9 Timing Requirements: V _{CCA} = 2.5 V ± 0.2 V7	12.1 Receiving Notification of Documentation Updates	.19
6.10 Timing Requirements: $V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V}8$	12.2 Support Resources	19
6.11 Switching Characteristics: V _{CCA} = 1.2 V8	12.3 Trademarks	.19
6.12 Switching Characteristics: V _{CCA} = 1.5 V ± 0.1 V8	12.4 Electrostatic Discharge Caution	.19
6.13 Switching Characteristics: V _{CCA} = 1.8 V ± 0.15 V9	12.5 Glossary	
6.14 Switching Characteristics: V _{CCA} = 2.5 V ± 0.2 V9	13 Mechanical, Packaging, and Orderable	
6.15 Switching Characteristics: V _{CCA} = 3.3 V ± 0.3 V9	Information	19
6.16 Operating Characteristics	13.1 Package Addendum	.20
6.17 Typical Characteristics11	•	

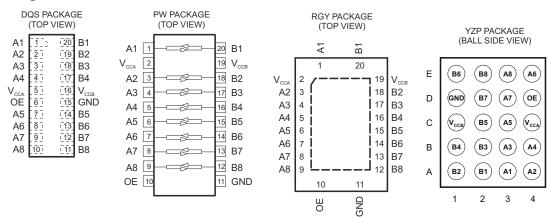
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

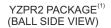
Changes from Revision G (December 2018) to Revision H (August 2020)	Page
 Updated the numbering format for tables, figures and cross-references through 	out the document1
Added NME package option to Device Information table	1
Added NME package to Figure 5-1	
Added NME package to Pin Assignments table	
Added NME package to Thermal Information table	
Changes from Revision F (November 2014) to Revision G (December 2018)	Page
Added pinout image for the ZYPR2 package option	3
Added text string 'GRID LOCATOR' to Pin Functions table YZP column to clarify Name'	•
Changes from Revision E (April 2012) to Revision F (October 2014)	Page
 Added Pin Configuration and Functions section, Handling Rating table, Feature 	December of the Decise
Functional Modes, Application and Implementation section, Power Supply Reco section, Device and Documentation Support section, and Mechanical, Packagin section	mmendations section, Layout g, and Orderable Information 1
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Functional Modes, Application and Implementation section, Power Supply Reco section, Device and Documentation Support section, and Mechanical, Packagin section Changed V _{OLA} value 0.9 to 0.3	mmendations section, Layout g, and Orderable Information 1

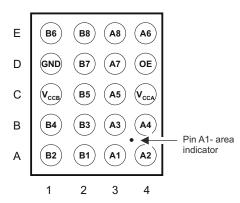


5 Pin Configuration and Functions



- A. For the RGY package, the exposed center thermal pad must be connected to ground.
- B. Pullup resistors are not required on both sides for Logic I/O.
- C. If pullup or pulldown resistors are needed, the resistor value must be over 50 k Ω .
- D. 50 k Ω is a safe recommended value, if the customer can accept higher V_{OL} or lower V_{OH} , smaller pullup or pulldown resistor is allowed, the draft estimation is $V_{OL} = V_{CCOUT} \times 4.5 \text{ k/}(4.5 \text{ k} + R_{PU})$ and $V_{OH} = V_{CCOUT} \times R_{DW}/(4.5 \text{ k} + R_{DW})$.
- E. If pullup resistors are needed, please refer to the TXS0108 or contact TI.
- F. For detailed information, please refer to application note SCEA043.





 $\ensuremath{^{(1)}\!\!}\mbox{See}$ orderable addendum at the end of the data sheet

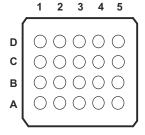


Figure 5-1. NME/GXY/ZXY PACKAGE (BOTTOM VIEW)



Pin Functions

PIN					
SIGNAL NAME	PW, RGY NO.	DQS NO.	YZP GRID LOCATOR	I/O ⁽¹⁾	FUNCTION
A1	1	1	A3	I/O	Input/output 1. Referenced to V _{CCA} .
V _{CCA}	2	5	C4	S	A-port supply voltage. 1.1 V ≤ V _{CCA} ≤ 3.6 V, V _{CCA} ≤ V _{CCB} .
A2	3	2	A4	I/O	Input/output 2. Referenced to V _{CCA} .
A3	4	3	В3	I/O	Input/output 3. Referenced to V _{CCA} .
A4	5	4	B4	I/O	Input/output 4. Referenced to V _{CCA} .
A5	6	7	C3	I/O	Input/output 5. Referenced to V _{CCA} .
A6	7	8	E4	I/O	Input/output 6. Referenced to V _{CCA} .
A7	8	9	D3	I/O	Input/output 7. Referenced to V _{CCA} .
A8	9	10	E3	I/O	Input/output 8. Referenced to V _{CCA} .
OE	10	6	D4	I	Output enable. Pull OE low to place all outputs in 3-state mode. Referenced to V _{CCA} .
GND	11	15	D1	S	Ground
В8	12	11	E2	I/O	Input/output 8. Referenced to V _{CCB} .
B7	13	12	D2	I/O	Input/output 7. Referenced to V _{CCB} .
В6	14	13	E1	I/O	Input/output 6. Referenced to V _{CCB} .
B5	15	14	C2	I/O	Input/output 5. Referenced to V _{CCB} .
B4	16	17	B1	I/O	Input/output 4. Referenced to V _{CCB} .
В3	17	18	B2	I/O	Input/output 3. Referenced to V _{CCB} .
B2	18	19	A1	I/O	Input/output 2. Referenced to V _{CCB} .
V _{CCB}	19	16	C1	S	B-port supply voltage. 1.65 V ≤ V _{CCB} ≤ 5.5 V.
B1	20	20	A2	I/O	Input/output 1. Referenced to V _{CCB} .
Thermal Pad		_		_	For the RGY package, the exposed center thermal pad must be connected to ground.

(1) I = input, O = output, I/O = input and output, S = power supply

Pin Assignments (20-Ball NME/GXY/ZXY Package)

	1	2	3	4	5
D	V _{CCB}	B2	B4	B6	B8
С	B1	В3	B5	B7	GND
В	A1	A3	A5	A7	OE
Α	V _{CCA}	A2	A4	A6	A8



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)

	(1)	,	MIN	MAX	UNIT
V_{CCA}	Supply voltage range	-0.5	4.6	V	
V _{CCB}	Supply voltage range		-0.5	6.5	V
VI	Input voltage range ⁽²⁾		-0.5	6.5	V
Vo	Voltage range applied to any output in the high-impedance or power	r-off state ⁽²⁾	-0.5	6.5	V
Vo	Voltage range applied to any output in the high or low state ⁽²⁾ (3)	A inputs	-0.5	V _{CCA} + 0.5	V
VO	voltage range applied to any output in the high or low state.	-0.5	V _{CCB} + 0.5	v	
I _{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
Io	Continuous output current		·	±50	mA
	Continuous current through V _{CCA} , V _{CCB} , or GND			±100	mA
T _{stg}	Storage temperature range		-65	150	°C
TJ	Junction temperature			150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 Handling Ratings

			MIN	MAX	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾ , A Port Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾ , B Port		2	
				15	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾ , A Port		1	kV
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾ , A Port (YZP Package only)	-8	8	
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾ , B Port		1	

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1) (2)

			V _{CCA}	V _{CCB}	MIN	MAX	UNIT
V_{CCA}	Supply voltage	vvoltage			1.2	3.6	V
V _{CCB}	Supply voltage				1.65	5.5	\ \ \ \
V	Data inputs 1.2 V to 3.6 V 1.65 V to 5.5 V		V _{CCI} x 0.65 ⁽³⁾	V _{CCI}	V		
V _{IH} High-level input voltage		OE	1.2 V to 3.6 V 1.65 V to 5.5		V _{CCA} x 0.65	5.5	\ \ \
V _{IL}	Low-level input voltage	Data inputs	1.2 V to 5.5 V	1.65 V to 5.5 V	0	V _{CCI} x 0.35 ⁽³⁾	V
VIL.	Low-level illput voltage	OE	1.2 V to 3.6 V	1.03 V to 3.3 V	0	V _{CCA} x 0.35	
		A-port inputs	1.2 V to 3.6 V	1.65 V to 5.5 V		40	
Δt/Δν	Input transition rise or fall rate	B-port inputs	1.2 V to 3.6 V	1.65 V to 3.6 V		40	ns/V
		D-port inputs	1.2 V 10 3.0 V	4.5 V to 5.5 V		30	

⁽²⁾ The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

⁽³⁾ The value of V_{CCA} and V_{CCB} are provided in the recommended operating conditions table.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions (continued)

over operating free-air temperature range (unless otherwise noted)(1) (2)

	V _{CCA}	V _{CCB}	MIN MAX	UNIT
T _A Operating free-air temperature			-40 85	°C

- (1) The A and B sides of an unused data I/O pair must be held in the same state, i.e., both at V_{CCI} or both at GND.
- (2) V_{CCA} must be less than or equal to V_{CCB} and must not exceed 3.6 V.
- (3) V_{CCI} is the supply voltage associated with the input port.

6.4 Thermal Information

			TXB0108						
THERMAL METRIC ⁽¹⁾			RGY	DQS	YZP	GXY	ZXY	NME	UNIT
					20 PINS				
$R_{\theta JA}$	Junction-to-ambient thermal resistance	101.8	35.3	108.5	66.2	156.7	156.7	131.4	°C/W
R _θ JC(top)	Junction-to-case (top) thermal resistance	35.5	42.1	32.3	0.4	39.9	39.9	56.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	52.8	11.1	42.4	52.0	85.9	85.9	83.2	°C/W
ΨЈТ	Junction-to-top characterization parameter	2.2	0.7	0.7	1.5	1.1	1.1	1.5	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	52.2	11.2	42	51.9	85.4	85.4	82.6	°C/W
R _θ JC(bot)	Junction-to-case (bottom) thermal resistance	_	3.8	_	_	_	_	_	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)(1) (2)

	DADAMETED	TEST	V	V	T _A :	= 25°C	;	-40°C to 8	5°C	LINUT	
	PARAMETER	CONDITIONS	V _{CCA}	V _{CCB}	MIN	TYP	MAX	MIN	MAX	UNIT	
,,		204	1.2 V			1.1				V	
V _{OHA}		I _{OH} = -20 μA	1.4 V to 3.6 V					V _{CCA} - 0.4		V	
,		204	1.2 V			0.3				V	
V _{OLA}		I _{OL} = 20 μA	1.4 V to 3.6 V						0.4	V	
V _{OHB}		I _{OH} = -20 μA		1.65 V to 5.5 V				V _{CCB} - 0.4		V	
V _{OLB}		I _{OL} = 20 μA		1.65 V to 5.5 V					0.4	V	
II	OE		1.2 V to 3.6 V	1.65 V to 5.5 V			±1		±2	μA	
	A port		0 V	0 V to 5.5 V			±1		±2		
I _{off}	B port		0 V to 3.6 V	0 V			±1		±2	μA	
I _{OZ}	A or B port	OE = GND	1.2 V to 3.6 V	1.65 V to 5.5 V			±1		±2	μΑ	
		1.2 V		1.65 V to 5.5 V		0.06					
		$V_I = V_{CCI}$ or GND,	1.4 V to 3.6 V	1.05 V 10 5.5 V					5		
I _{CCA}		I _O = 0	3.6 V	0 V					2	μA	
			0 V	5.5 V					-2		
			1.2 V	1.65 V to 5.5 V		3.4					
		$V_I = V_{CCI}$ or GND,	1.4 V to 3.6 V	1.05 V 10 5.5 V					5		
I _{CCB}		I _O = 0	3.6 V	0 V					-2	μA	
			0 V	5.5 V					2		
	1	$V_I = V_{CCI}$ or GND,	1.2 V	1 GE V to E E V		3.5					
I _{CCA} +	CCB	I _O = 0	1.4 V to 3.6 V	1.65 V to 5.5 V					10	μA	
		$V_I = V_{CCI}$ or GND,	1.2 V			0.05					
I _{CCZA}		I _O = 0, OE = GND	1.4 V to 3.6 V	1.65 V to 5.5 V					5	μA	

6.5 Electrical Characteristics (continued)

over recommended operating free-air temperature range (unless otherwise noted)(1) (2)

PARAMETER		TEST V _{CCA}		V _{CCB}	T _A = 25°C			-40°C to 85°C		UNIT
		CONDITIONS	▼CCA	∨ ССВ	MIN T	TYP	MAX	MIN	MAX	O.u.
		$V_I = V_{CCI}$ or GND,	1.2 V			3.3				
I _{CCZB}		I _O = 0, OE = GND 1.4 V to		1.65 V to 5.5 V					5	μA
C _I	OE		1.2 V to 3.6 V	1.65 V to 5.5 V		5			5.5	pF
C _{io}	A port		1.2 V to 3.6 V	1.65 V to 5.5 V		5			6.5	pF
Oio	B port		1.2 V to 5.0 V	1.03 V to 3.3 V		8			10	Pi

- (1) V_{CCI} is the supply voltage associated with the input port.
- (2) V_{CCO} is the supply voltage associated with the output port.

6.6 Timing Requirements: V_{CCA} = 1.2 V

 $T_A = 25^{\circ}C, V_{CCA} = 1.2 \text{ V}$

			V _{CCB} = 1.8 V	V _{CCB} = 2.5 V	V _{CCB} = 3.3 V	V _{CCB} = 5 V	UNIT	
			TYP	TYP	TYP	TYP	ONIT	
		Data rate		20	20	20	20	Mbps
	t _w	Pulse duration	Data inputs	50	50	50	50	ns

6.7 Timing Requirements: $V_{CCA} = 1.5 V \pm 0.1 V$

over recommended operating free-air temperature range, V_{CCA} = 1.5 V ± 0.1 V (unless otherwise noted)

	,	, ,	J ,	CCA	-	-	`			,	
			V _{CCB} = ± 0.1		V _{CCB} = ± 0.2		V _{CCB} = ± 0.3		V _{CCB} = ± 0.5		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
	Data rate			50		50		50		50	Mbps
t _w	Pulse duration	Data inputs	20		20		20		20		ns

6.8 Timing Requirements: V_{CCA} = 1.8 V ± 0.15 V

over recommended operating free-air temperature range, V_{CCA} = 1.8 V ± 0.15 V (unless otherwise noted)

			V _{CCB} = ± 0.1		V _{CCB} = ± 0.2		V _{CCB} = ± 0.3		V _{CCB} = ± 0.5		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
	Data rate			52		60		60		60	Mbps
t _w	Pulse duration	Data inputs	19		17		17		17		ns

6.9 Timing Requirements: V_{CCA} = 2.5 V ± 0.2 V

over recommended operating free-air temperature range, $V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V}$ (unless otherwise noted)

				V _{CCB} = 2.5 V ± 0.2 V		3.3 V V	V _{CCB} = 5 V ± 0.5 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
	Data rate			70		100		100	Mbps
t _w	Pulse duration	Data inputs	14		10		10		ns



6.10 Timing Requirements: $V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range, V_{CCA} = 3.3 V ± 0.3 V (unless otherwise noted)

			V _{CCB} = 3 ± 0.3 \	.3 V /	V _{CCB} = ± 0.5	5 V V	UNIT
			MIN	MAX	MIN	MAX	
	Data rate			100		100	Mbps
t _w	Pulse duration	Data inputs	10		10		ns

6.11 Switching Characteristics: $V_{CCA} = 1.2 \text{ V}$

 $T_A = 25^{\circ}C, V_{CCA} = 1.2 V$

PARAMETER	FROM	то	V _{CCB} = 1.8 V	V _{CCB} = 2.5 V	V _{CCB} = 3.3 V	V _{CCB} = 5 V	UNIT
PARAMETER	(INPUT)	(OUTPUT)	TYP	TYP	TYP	TYP	UNII
•	Α	В	9.5	7.9	7.6	8.5	ne
t _{pd}	В	Α	9.2	8.8	8.4	8	ns
	OE	Α	1	1	1	1	
t _{en}	OE	В	1	1	1	1	μs
	OE	A	20	17	17	18	no
t _{dis}	OE	В	20	16	15	15	ns
t _{rA} , t _{fA}	A-port rise a	and fall times	4.1	4.4	4.1	3.9	ns
t _{rB} , t _{fB}	B-port rise a	and fall times	5	5	5.1	5.1	ns
t _{SK(O)}	Channel-to-c	channel skew	2.4	1.7	1.9	7	ns
Max data rate			20	20	20	20	Mbps

6.12 Switching Characteristics: V_{CCA} = 1.5 V ± 0.1 V

over recommended operating free-air temperature range, V_{CCA} = 1.5 V ± 0.1 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = ± 0.1		V _{CCB} = ± 0.2		V _{CCB} = ± 0.3		V _{CCB} = ± 0.5		UNIT
	(INFOT)	(OUTFUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
+ .	Α	В	1.4	12.9	1.2	10.1	1.1	10	0.8	9.9	ns
t _{pd}	В	Α	0.9	14.2	0.7	12	0.4	11.7	0.3	13.7	115
+	OE	Α		1		1		1		1	
t _{en}	OL	В		1		1		1		1	μs
4	OE	A	6.6	33	6.4	25.3	6.1	23.1	5.9	24.6	
t _{dis}	OL	В	6.6	35.6	5.8	25.6	5.5	22.1	5.6	20.6	ns
t _{rA} , t _{fA}	A-port rise a	nd fall times	0.8	6.5	0.8	6.3	0.8	6.3	0.8	6.3	ns
t _{rB} , t _{fB}	B-port rise a	ind fall times	1	7.3	0.7	4.9	0.7	4.6	0.6	4.6	ns
t _{SK(O)}	Channel-to-c	channel skew		2.6		1.9		1.6		1.3	ns
Max data rate			50		50		50		50		Mbps

6.13 Switching Characteristics: V_{CCA} = 1.8 V ± 0.15 V

over recommended operating free-air temperature range, V_{CCA} = 1.8 V ± 0.15 V (unless otherwise noted)

PARAMETER	FROM	FROM TO (INPUT) (OUTPUT)		V _{CCB} = 1.8 V ± 0.15 V		V _{CCB} = 2.5 V ± 0.2 V		3.3 V V	V _{CCB} = 5 V ± 0.5 V		UNIT
	(INFOT)	(OUTFUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
4	Α	В	1.6	11	1.4	7.7	1.3	6.8	1.2	6.5	
t _{pd}	В	Α	1.5	12	1.2	8.4	0.8	7.6	0.5	7.1	ns
4	OE	Α		1		1		1		1	
t _{en}	OL	В		1		1		1		1	μs
	OE	Α	5.9	26.7	5.6	21.6	5.4	18.9	4.8	18.7	
t _{dis}	OE	В	6.1	33.9	5.2	23.7	5	19.9	5	17.6	ns
t _{rA} , t _{fA}	A-port rise a	ind fall times	0.7	5.1	0.7	5	1	5	0.7	5	ns
t _{rB} , t _{fB}	B-port rise a	ind fall times	1	7.3	0.7	5	0.7	3.9	0.6	3.8	ns
t _{SK(O)}	Channel-to-c	channel skew		0.8		0.7		0.6		0.6	ns
Max data rate			52		60		60		60		Mbps

6.14 Switching Characteristics: $V_{CCA} = 2.5 V \pm 0.2 V$

over recommended operating free-air temperature range, V_{CCA} = 2.5 V ± 0.2 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = : ± 0.2		V _{CCB} = 3 ± 0.3		V _{CCB} = 5 V ± 0.5 V		UNIT
	(INFOT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	
	Α	В	1.1	6.4	1	5.3	0.9	4.7	no
t _{pd}	В	A	1	7	0.6	5.6	0.3	4.4	ns
+	OE	A		1		1		1	ше
t _{en}	OL	В		1		1		1	μs
	OE	A	5	16.9	4.9	15	4.5	13.8	ns
t _{dis}	OL	В	4.8	21.8	4.5	17.9	4.4	15.2	115
t _{rA} , t _{fA}	A-port rise a	and fall times	0.8	3.6	0.6	3.6	0.5	3.5	ns
t _{rB} , t _{fB}	B-port rise a	and fall times	0.6	4.9	0.7	3.9	0.6	3.2	ns
t _{SK(O)}	Channel-to-c	channel skew		0.4		0.3		0.3	ns
Max data rate			70		100		100		Mbps

6.15 Switching Characteristics: V_{CCA} = 3.3 V ± 0.3 V

over recommended operating free-air temperature range, $V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 3 ± 0.3		V _{CCB} = 5 ± 0.5 \		UNIT
	(INFOT)	(OUTPOT)	MIN	MAX	MIN	MAX	
•	Α	В	0.9	4.9	0.8	4	ns
t _{pd}	В	A	0.5	5.4	0.2	4	115
4	OE	Α		1		1	
t _{en}	OE	В		1		1	μs
	OE	Α	4.5	13.9	4.1	12.4	200
t _{dis}	OE	В	4.1	17.3	4	14.4	ns
t _{rA} , t _{fA}	A-port rise a	and fall times	0.5	3	0.5	3	ns
t _{rB} , t _{fB}	B-port rise a	and fall times	0.7	3.9	0.6	3.2	ns
t _{SK(O)}	Channel-to-c	channel skew		0.4		0.3	ns
Max data rate			100		100		Mbps

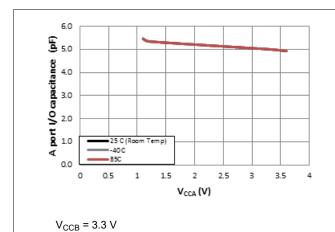


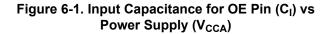
6.16 Operating Characteristics

 $T_A = 25^{\circ}C$

						V _{CCA}				
			1.2 V	1.2 V	1.5 V	1.8 V	2.5 V	2.5 V	3.3 V	
						V _{CCB}				
	PARAMETER	TEST CONDITIONS	5 V	1.8 V	1.8 V	1.8 V	2.5 V	5 V	3.3 V to 5 V	UNIT
			TYP	TYP	TYP	TYP	TYP	TYP	TYP	
C	A-port input, B-port output	$C_1 = 0, f = 10 \text{ MHz},$	9	8	7	7	7	7	8	
C _{pdA}	B-port input, A-port output	$t_r = t_f = 1 \text{ ns},$	12	11	11	11	11	11	11	pF
C	A-port input, B-port output	OE = V _{CCA}	35	26	27	27	27	27	28	pi
C _{pdB}	B-port input, A-port output	(outputs enabled)	26	19	18	18	18	20	21	
C_{pdA}	A-port input, B-port output	$C_1 = 0, f = 10 \text{ MHz},$	0.01	0.01	0.01	0.01	0.01	0.01	0.01	
OpdA	B-port input, A-port output	$t_r = t_f = 1 \text{ ns},$ $OE = GND$	0.01	0.01	0.01	0.01	0.01	0.01	0.01	pF
C	A-port input, B-port output		0.01	0.01	0.01	0.01	0.01	0.01	0.03	hc
C _{pdB}	B-port input, A-port output (outputs disabled)	0.01	0.01	0.01	0.01	0.01	0.01	0.03		

6.17 Typical Characteristics





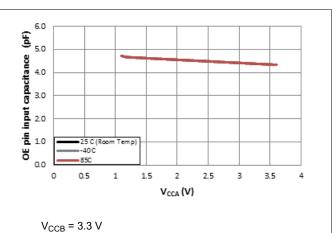
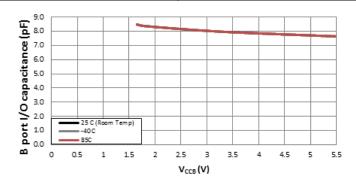


Figure 6-2. Capacitance for A Port I/O Pins (C_{IO}) vs Power Supply (V_{CCA})

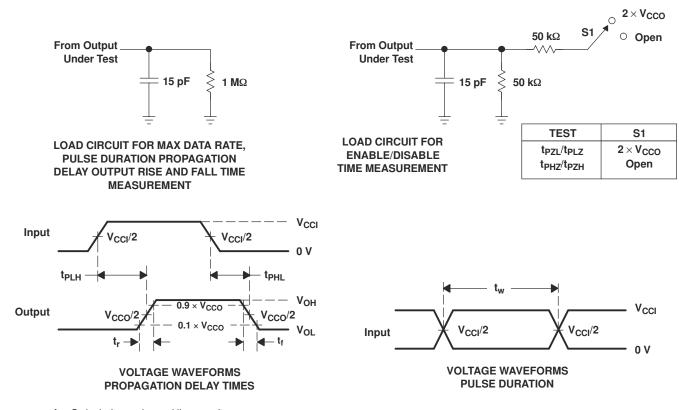


V_{CCA} = 1.8 V

Figure 6-3. Capacitance fpr B Port I/O Pins (C_{IO}) vs Power Supply (V_{CCB})



7 Parameter Measurement Information



- A. C_L includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $dv/dt \geq 1 V/ns$.
- C. The outputs are measured one at a time, with one transition per measurement.
- D. t_{PLH} and t_{PHL} are the same as t_{pd} .
- E. V_{CCI} is the V_{CC} associated with the input port.
- F. V_{CCO} is the V_{CC} associated with the output port.
- G. All parameters and waveforms are not applicable to all devices.

Figure 7-1. Load Circuits and Voltage Waveforms

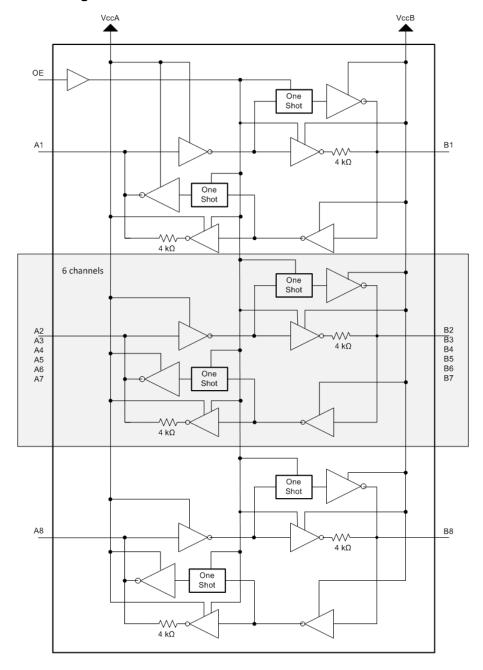


8 Detailed Description

8.1 Overview

The TXB0108 device is an 8-bit, directionless voltage-level translator specifically designed for translating logic voltage levels. The A port is able to accept I/O voltages ranging from 1.2 V to 3.6 V, while the B port can accept I/O voltages from 1.65 V to 5.5 V. The device is a buffered architecture with edge-rate accelerators (one-shots) to improve the overall data rate. This device can only translate push-pull CMOS logic outputs. If for open-drain signal translation, please refer to TI TXS products.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Architecture

The TXB0108 architecture (see Figure 8-1) does not require a direction-control signal to control the direction of data flow from A to B or from B to A. In a dc state, the output drivers of the TXB0108 can maintain a high or low, but are designed to be weak so that they can be overdriven by an external driver when data on the bus starts flowing the opposite direction. The output one-shots detect rising or falling edges on the A or B ports. During a rising edge, the one-shot turns on the PMOS transistors (T1, T3) for a short duration, which speeds up the low-to-high transition. Similarly, during a falling edge, the one-shot turns on the NMOS transistors (T2, T4) for a short duration, which speeds up the high-to-low transition. The typical output impedance during output transition is 70 Ω at VCCO = 1.2 V to 1.8 V, 50 Ω at VCCO = 1.8 V to 3.3 V and 40 Ω at VCCO = 3.3 V to 5 V.

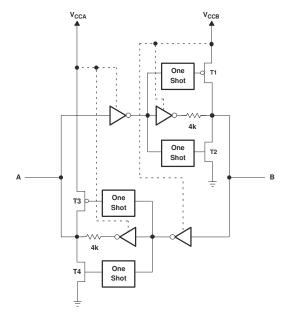
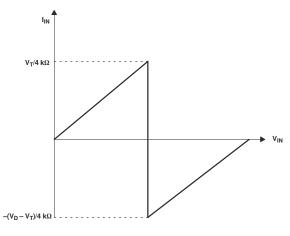


Figure 8-1. Architecture of TXB0108 I/O Cell

8.3.2 Input Driver Requirements

Typical I_{IN} vs V_{IN} characteristics of the TXB0108 are shown in Figure 8-2. For proper operation, the device driving the data I/Os of the TXB0108 must have drive strength of at least ± 2 mA.



A. V_T is the input threshold voltage of the TXB0108 (typically $V_{CCI}/2$).

B. V_D is the supply voltage of the external driver

Figure 8-2. Typical I_{IN} vs V_{IN} Curve

8.3.3 Output Load Considerations

TI recommends careful PCB layout practices with short PCB trace lengths to avoid excessive capacitive loading and to ensure that proper O.S. triggering takes place. PCB signal trace-lengths should be kept short enough such that the round-trip delay of any reflection is less than the one-shot duration. This improves signal integrity by ensuring that any reflection sees a low impedance at the driver. The O.S. circuits have been designed to stay on for approximately 10 ns. The maximum capacitance of the lumped load that can be driven also depends directly on the one-shot duration. With very heavy capacitive loads, the one-shot can time-out before the signal is driven fully to the positive rail. The O.S. duration has been set to best optimize trade-offs between dynamic ICC, load driving capability, and maximum bit-rate considerations. Both PCB trace length and connectors add to the capacitance that the TXB0108 output sees, so it is recommended that this lumped-load capacitance be considered to avoid O.S. re-triggering, bus contention, output signal oscillations, or other adverse system-level affects.

8.3.4 Enable and Disable

The TXB0108 has an OE input that is used to disable the device by setting OE = low, which places all I/Os in the high-impedance (Hi-Z) state. The disable time (tdis) indicates the delay between when OE goes low and when the outputs actually get disabled (Hi-Z). The enable time (ten) indicates the amount of time the user must allow for the one-shot circuitry to become operational after the OE is high.

8.3.5 Pullup or Pulldown Resistors on I/O Lines

The TXB0108 is designed to drive capacitive loads of up to 70 pF. The output drivers of the TXB0108 have low dc drive strength. If pullup or pulldown resistors are connected externally to the data I/Os, their values must be kept higher than 50 k Ω to ensure that they do not contend with the output drivers of the TXB0108. For the same reason, the TXB0108 should not be used in applications such as I2C or 1-Wire where an open-drain driver is connected on the bidirectional data I/O. For these applications, use a device from the TI TXS01xx series of level translators.

8.4 Device Functional Modes

The TXB0108 device has two functional modes, enabled and disabled. To disable the device, set the OE input low, which places all I/Os in a high impedance state. Setting the OE input high will enable the device.

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TXB0108 can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. It can only translate push-pull CMOS logic outputs. If for open-drain signal translation, please refer to TI TXS010X products. Any external pulldown or pullup resistors are recommended to be larger than $50k\Omega$.

9.2 Typical Application

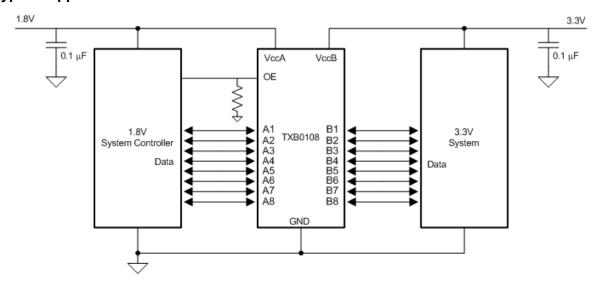


Figure 9-1. Typical Operating Circuit

9.2.1 Design Requirements

For this design example, use the parameters listed in Table 9-1. Make sure the VCCA ≤VCCB.

Table 9-1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range	1.2 V to 3.6 V
Output voltage range	1.65 V to 5.5 V

9.2.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range
- Use the supply voltage of the device that is driving the TXB0108 device to determine the input voltage range. For a valid logic high the value must exceed the VIH of the input port. For a valid logic low, the value must be less than the VIL of the input port.
- Output voltage range
- Use the supply voltage of the device that the TXB0108 device is driving to determine the output voltage range.

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- Do not recommend having the external pullup or pulldown resistors. If mandatory, it is recommended the value should be larger than 50 k Ω .
- An external pulldown or pullup resistor decreases the output V_{OH} and V_{OL} . Use the below equations to draft estimate the V_{OH} and V_{OL} as a result of an external pulldown and pullup resistor.

$$V_{OH} = V_{CCx} \times R_{PD} / (R_{PD} + 4.5 \text{ k}\Omega)$$

$$V_{OI} = V_{CCx} \times 4.5 k\Omega / (R_{PU} + 4.5 k\Omega)$$

Where:

- V_{CCx} is the output port supply voltage on either VCCA or VCCB
- R_{PD} is the value of the external pull down resistor
- R_{PU} is the value of the external pull up resistor
- 4.5 k Ω is the counting the variation of the serial resistor 4 k Ω in the I/O line. Refer to the Effects of external pullup and pulldown resistors on TXB application note

9.2.3 Application Curves

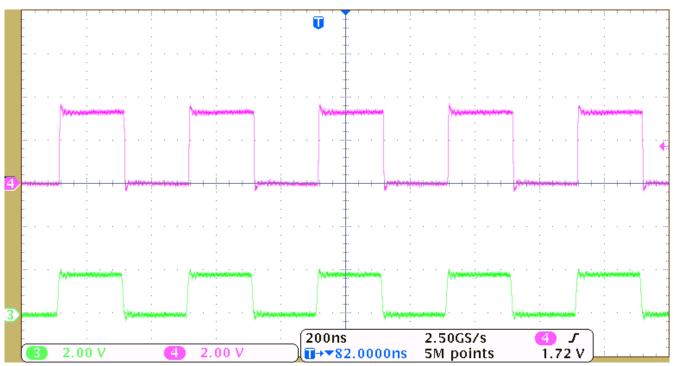


Figure 9-2. Level-Translation of a 2.5-MHz Signal

10 Power Supply Recommendations

During operation, ensure that $V_{CCA} \le V_{CCB}$ at all times. During power-up sequencing, $V_{CCA} \ge V_{CCB}$ does not damage the device, so any power supply can be ramped up first. The TXB0108 has circuitry that disables all output ports when either VCC is switched off ($V_{CCA/B} = 0 \text{ V}$).

The output-enable (OE) input circuit is designed so that it is supplied by V_{CCA} and when the (OE) input is low, all outputs are placed in the high-impedance state. To ensure the high-impedance state of the outputs during power-up or power-down, the OE input pin must be tied to GND through a pulldown resistor and must not be enabled until V_{CCA} and V_{CCB} are fully ramped and stable. The minimum value of the pulldown resistor to ground is determined by the current-sourcing capability of the driver.

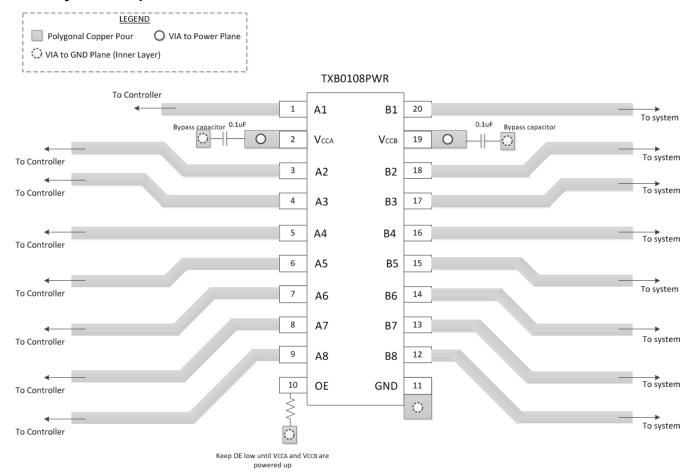
11 Layout

11.1 Layout Guidelines

To ensure reliability of the device, the following common printed-circuit board layout guidelines is recommended.

- Bypass capacitors should be used on power supplies and should be placed as close as possible to the V_{CCA},
 V_{CCB} pin and GND pin.
- Short trace lengths should be used to avoid excessive loading.
- PCB signal trace-lengths must be kept short enough so that the round-trip delay of any reflection is less than
 the one-shot duration, approximately 10 ns, ensuring that any reflection encounters low impedance at the
 source driver.

11.2 Layout Example



12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



13.1 Package Addendum

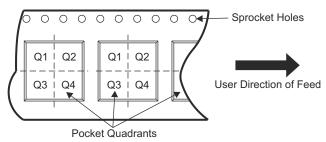
13.1.1 Tape and Reel Information

REEL DIMENSIONS Reel Diameter Reel Width (W1)

TAPE DIMENSIONS KO P1 BO W Cavity

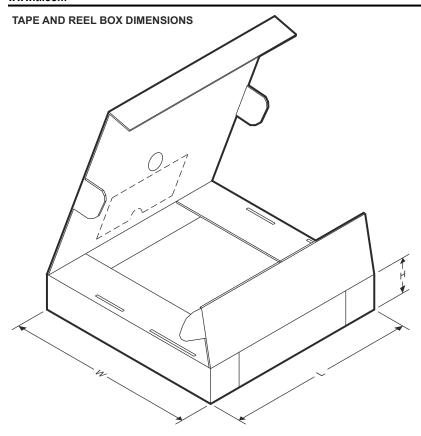
A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TXB0108DQSR	USON	DQS	20	3000	177.8	12.4	2.21	4.22	0.81	4.0	12.0	Q1
TXB0108RGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1
TXB0108YZPR	DSBGA	YZP	20	3000	180.0	8.4	1.99	2.49	0.56	4.0	8.0	Q1
TXB0108YZPR2	DSBGA	YZP	20	3000	180.0	8.4	1.99	2.49	0.56	4.0	8.0	Q2
TXB0108ZXYR	BGA MICROSTAR JUNIOR	ZXY	20	2500	330.0	12.4	2.8	4.22	3.3	1.0	12.0	Q2



Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TXB0108DQSR	USON	DQS	20	3000	202.0	201.0	28.0
TXB0108RGYR	VQFN	RGY	20	3000	355.0	350.0	50.0
TXB0108YZPR	DSBGA	YZP	20	3000	182.0	182.0	20.0
TXB0108YZPR2	DSBGA	YZP	20	3000	182.0	182.0	20.0
TXB0108ZXYR	BGA MICROSTAR JUNIOR	ZXY	20	2500	336.6	336.6	28.6

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TXB0108DQSR	ACTIVE	USON	DQS	20	3000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	5MR 5MH	Samples
TXB0108NMER	ACTIVE	NFBGA	NME	20	2500	RoHS & Green	SNAGCU	Level-2-260C-1 YEAR	-40 to 85	29WW	Samples
TXB0108PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YE08	Samples
TXB0108PWRG4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YE08	Samples
TXB0108RGYR	ACTIVE	VQFN	RGY	20	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YE08	Samples
TXB0108YZPR	ACTIVE	DSBGA	YZP	20	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 85	5M	Samples
TXB0108YZPR2	ACTIVE	DSBGA	YZP	20	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 85	EK	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

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(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

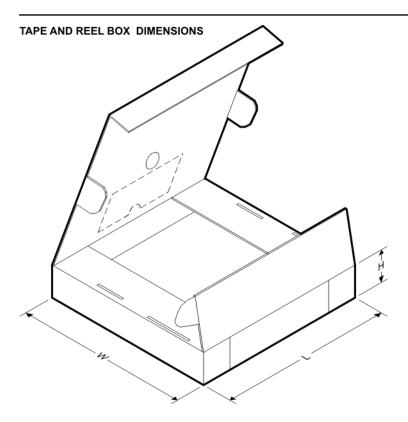


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TXB0108DQSR	USON	DQS	20	3000	177.8	12.4	2.21	4.22	0.81	4.0	12.0	Q1
TXB0108NMER	NFBGA	NME	20	2500	330.0	12.4	2.75	3.45	1.05	4.0	12.0	Q2
TXB0108PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
TXB0108RGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1
TXB0108YZPR	DSBGA	YZP	20	3000	180.0	8.4	1.99	2.49	0.56	4.0	8.0	Q1
TXB0108YZPR2	DSBGA	YZP	20	3000	180.0	8.4	1.99	2.49	0.56	4.0	8.0	Q2

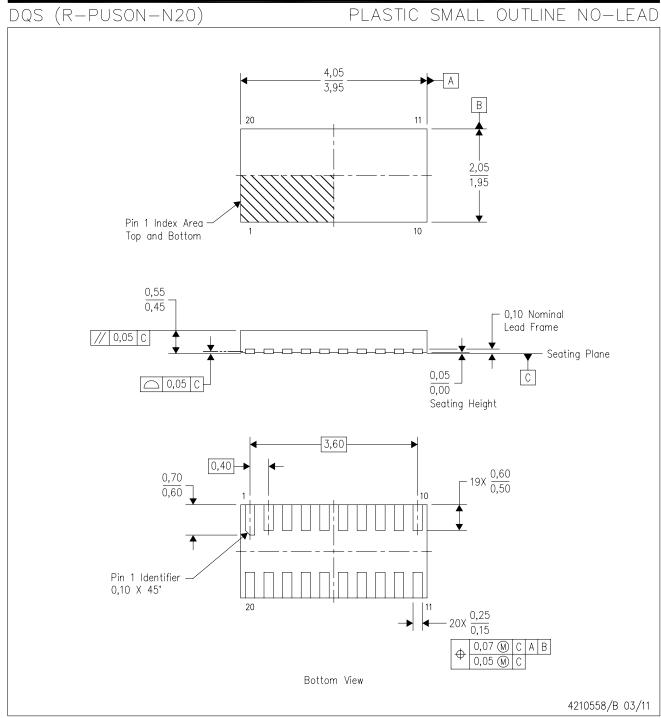


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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TXB0108DQSR	USON	DQS	20	3000	202.0	201.0	28.0
TXB0108NMER	NFBGA	NME	20	2500	336.6	336.6	31.8
TXB0108PWR	TSSOP	PW	20	2000	853.0	449.0	35.0
TXB0108RGYR	VQFN	RGY	20	3000	853.0	449.0	35.0
TXB0108YZPR	DSBGA	YZP	20	3000	182.0	182.0	20.0
TXB0108YZPR2	DSBGA	YZP	20	3000	182.0	182.0	20.0



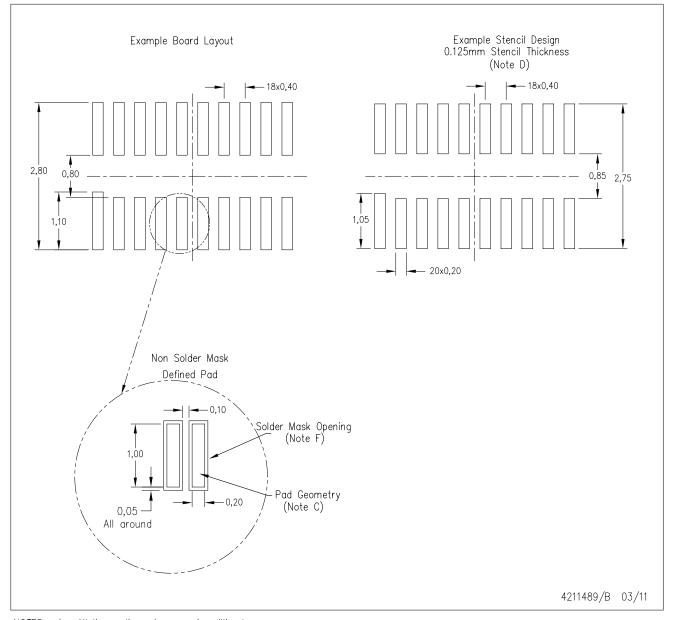
NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. SON (Small Outline No-Lead) package configuration.



DQS (R-PUSON-N20)

PLASTIC SMALL OUTLINE NO-LEAD



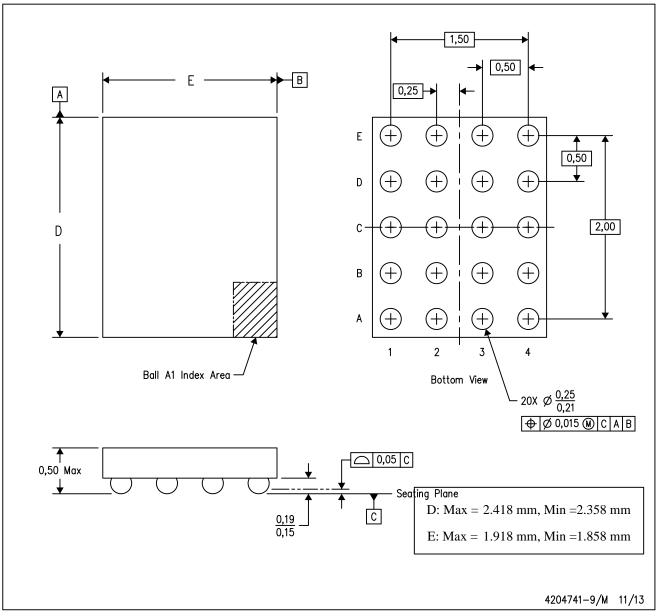
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- E. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



YZP (R-XBGA-N20)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.

NanoFree is a trademark of Texas Instruments.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

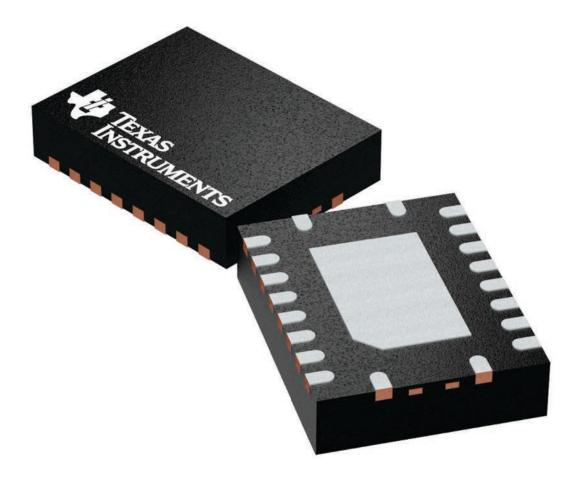
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



3.5 x 4.5, 0.5 mm pitch

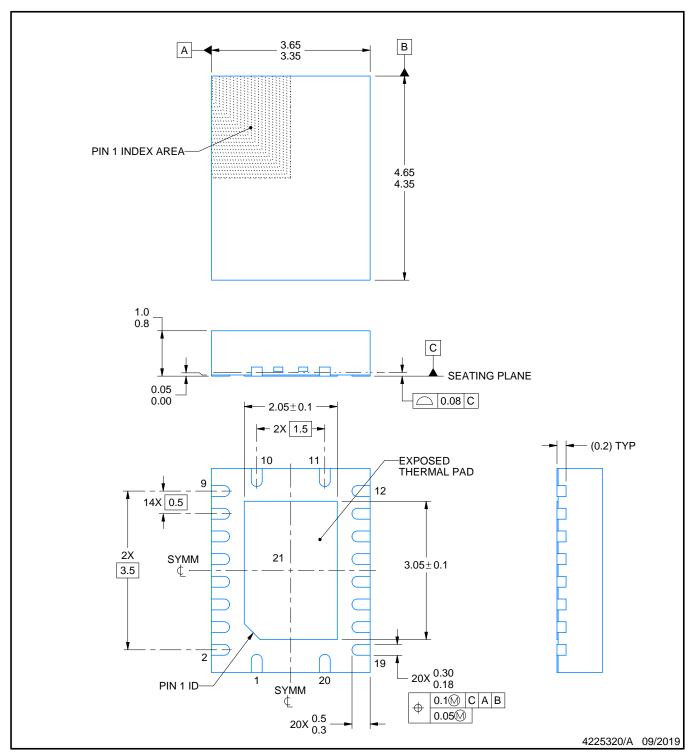
PLASTIC QUAD FGLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

PLASTIC QUAD FLATPACK - NO LEAD

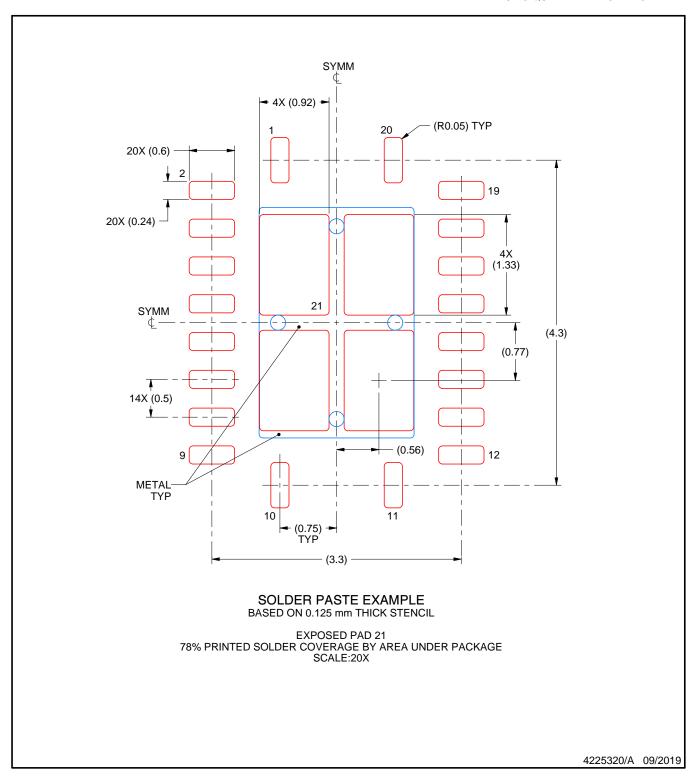


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



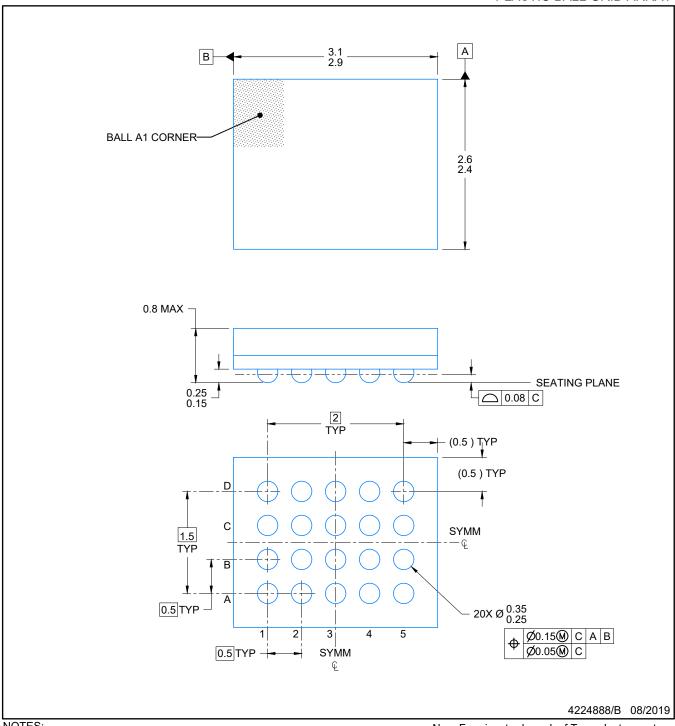
PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

PLASTIC BALL GRID ARRAY



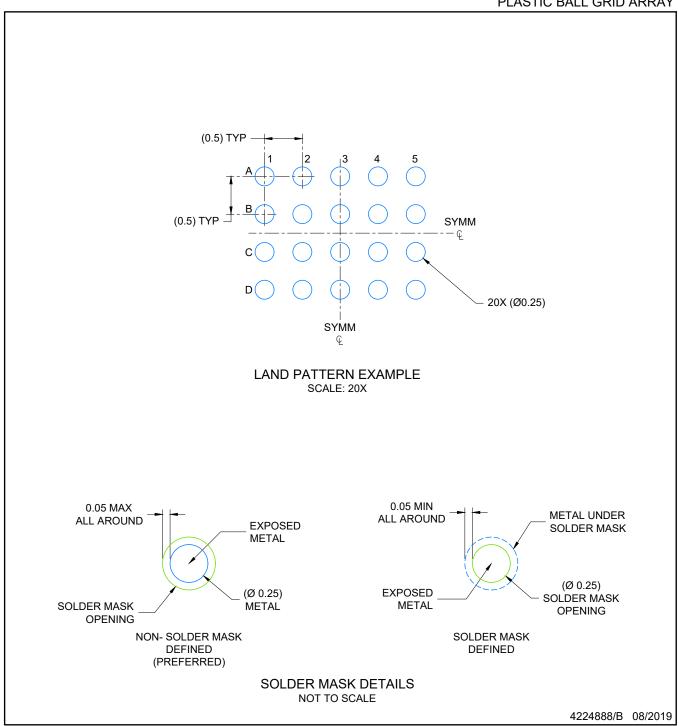
NOTES:

NanoFree is a trademark of Texas Instruments.

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.

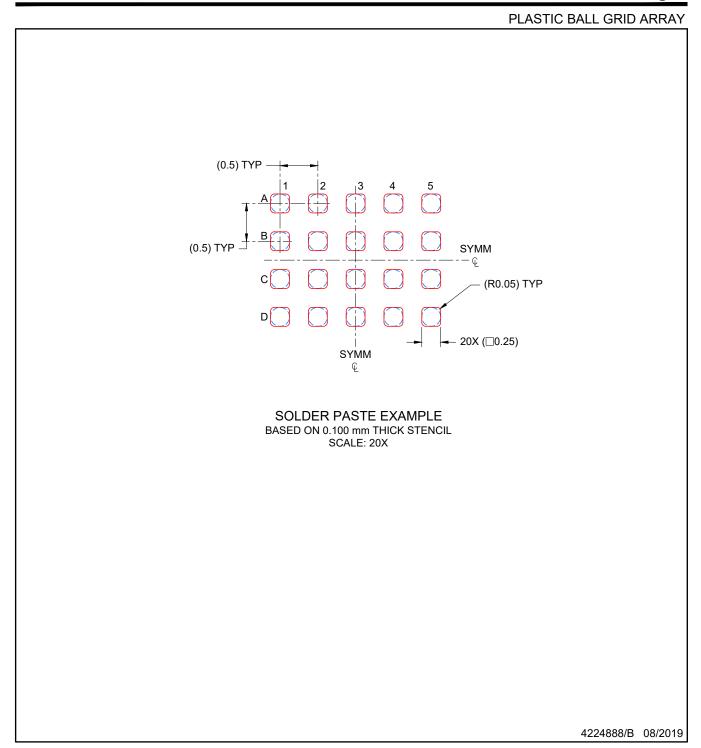


PLASTIC BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. Refer to Texas Instruments Literature number SNVA009 (www.ti.com/lit/snva009).



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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